Intelligent Data Analysis in Cyberspace

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closed (30 April 2023)

Message from the Guest Editors

Dear Colleagues,

This Special Issue solicits papers on new research achievements and challenges in intelligent data analysis in cyberspace.

Topics of interest in this Special Issue include but are not limited to the following:

- Information Retrieval for Cyberspace
- Data Model and Structure for Big Data
- Machine Learning Theory for Big Data
- Modeling Cyberspace and Behaviour
- Big Data Analytics and Processing
- Big Data Representation and Visualization
- Architectures and Designs of Big Data Processing Systems
- Recommender Systems Applications in Cyberspace
- Social Bot Detection and Behaviour Analysis in Cyberspace
- Knowledge Graph in Cyberspace

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Special Issue

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Message from the Editor-in-Chief

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